

Maximum Ratings (@T_A = +25°C, unless otherwise specified.)

| Characteristic | | | Symbol | Value | Units |
|---|--------------|------------------------|------------------|-------|-------|
| Drain-Source Voltage | | | V _{DSS} | -12 | V |
| Gate-Source Voltage | | | V _{GSS} | ±8 | V |
| Continuous Drain Current (Note 5) V _{GS} = -4.5V | Steady State | T _A = +25°C | I _D | 4.0 | A |
| | | T _A = +70°C | | 3.1 | |
| Continuous Drain Current (Note 5) V _{GS} = -2.5V | Steady State | T _A = +25°C | I _D | 3.3 | A |
| | | T _A = +70°C | | 2.6 | |
| Continuous Drain Current (Note 6) V _{GS} = -4.5V | Steady State | T _A = +25°C | I _D | 5.2 | A |
| | | T _A = +70°C | | 4.2 | |
| Continuous Drain Current (Note 6) V _{GS} = -2.5V | Steady State | T _A = +25°C | I _D | 4.3 | A |
| | | T _A = +70°C | | 3.4 | |
| Maximum Continuous Body Diode Forward Current (Note 6) | | | I _S | 2 | A |
| Pulsed Drain Current (10μs Pulse, Duty Cycle = 1%) (Note 5) | | | I _{DM} | 40 | A |

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Value | Units |
|--|-----------------------------------|-------------|-------|
| Total Power Dissipation (Note 5) | P _D | 0.8 | W |
| Thermal Resistance, Junction to Ambient (Note 5) | R _{θJA} | 168 | °C/W |
| Total Power Dissipation (Note 6) | P _D | 1.3 | W |
| Thermal Resistance, Junction to Ambient (Note 6) | R _{θJA} | 99 | °C/W |
| Thermal Resistance, Junction to Case (Note 6) | R _{θJC} | 14.8 | °C/W |
| Operating and Storage Temperature Range | T _J , T _{STG} | -55 to +150 | °C |

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Min | Typ | Max | Unit | Test Condition |
|--|---------------------|------|-------|------|------|--|
| OFF CHARACTERISTICS (Note 7) | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | -12 | — | — | V | V _{GS} = 0V, I _D = -250μA |
| Zero Gate Voltage Drain Current (T _J = +25°C) | I _{DSS} | — | — | -1.0 | μA | V _{DS} = -12V, V _{GS} = 0V |
| Gate-Source Leakage | I _{GSS} | — | — | ±10 | μA | V _{GS} = ±8V, V _{DS} = 0V |
| ON CHARACTERISTICS (Note 7) | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | -0.3 | -0.55 | -1.0 | V | V _{DS} = V _{GS} , I _D = -250μA |
| Static Drain-Source On-Resistance | R _{DS(ON)} | — | 26 | 31 | mΩ | V _{GS} = -4.5V, I _D = -4.0A |
| | | | 31 | 45 | | V _{GS} = -2.5V, I _D = -3.5A |
| | | | 45 | 75 | | V _{GS} = -1.8V, I _D = -2.7A |
| Forward Transfer Admittance | Y _{FS} | — | 12 | — | S | V _{DS} = -5V, I _D = -4A |
| Diode Forward Voltage | V _{SD} | — | -0.6 | — | V | V _{GS} = 0V, I _S = -1A |
| DYNAMIC CHARACTERISTICS (Note 8) | | | | | | |
| Input Capacitance | C _{ISS} | — | 1357 | — | pF | V _{DS} = -10V, V _{GS} = 0V f = 1.0MHz |
| Output Capacitance | C _{OSS} | — | 504 | — | pF | |
| Reverse Transfer Capacitance | C _{RSS} | — | 235 | — | pF | |
| Gate Resistnace | R _G | — | 14.1 | — | Ω | V _{DS} = 0V, V _{GS} = 0V, f = 1.0MHz |
| SWITCHING CHARACTERISTICS (Note 8) | | | | | | |
| Total Gate Charge | Q _G | — | 15.8 | — | nC | V _{GS} = -4.5V, V _{DS} = -10V, I _D = -4A |
| Gate-Source Charge | Q _{GS} | — | 2.0 | — | nC | |
| Gate-Drain Charge | Q _{GD} | — | 3.9 | — | nC | |
| Turn-On Delay Time | t _{D(ON)} | — | 15.7 | — | ns | V _{DS} = -10V, V _{GS} = -4.5V, R _L = 2.5Ω, R _G = 3.0Ω |
| Turn-On Rise Time | t _R | — | 23.3 | — | ns | |
| Turn-Off Delay Time | t _{D(OFF)} | — | 91.2 | — | ns | |
| Turn-Off Fall Time | t _F | — | 106.9 | — | ns | |

- Notes:
- Device mounted on FR-4 PCB with minimum recommended pad layout, single sided.
 - Device mounted on FR-4 substrate PCB, 2oz copper, with thermal vias to bottom layer 1-inch square copper plate.
 - Short duration pulse test used to minimize self-heating effect.
 - Guaranteed by design. Not subject to production testing.

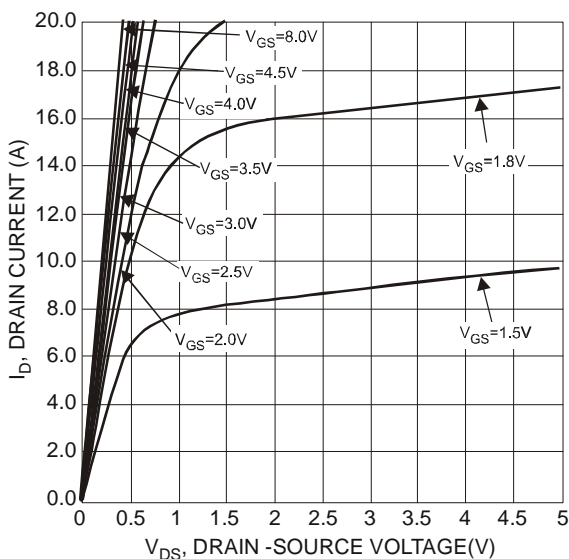


Fig. 1 Typical Output Characteristics

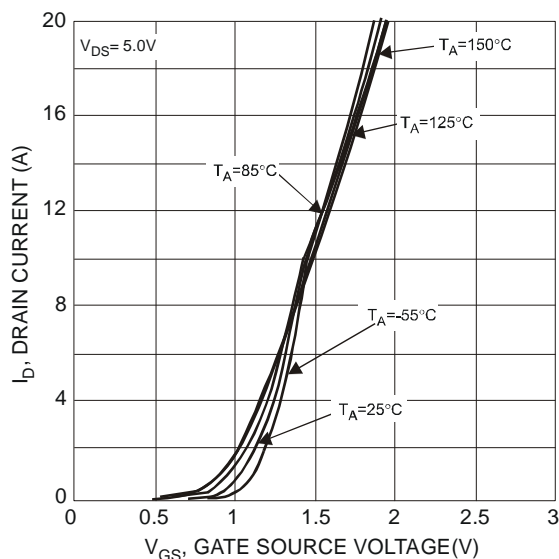


Fig. 2 Typical Transfer Characteristics

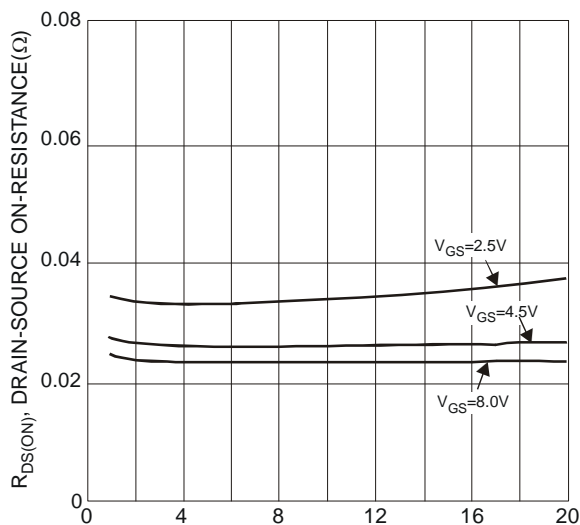


Fig. 3 Typical On-Resistance vs. Drain Current and Gate Voltage

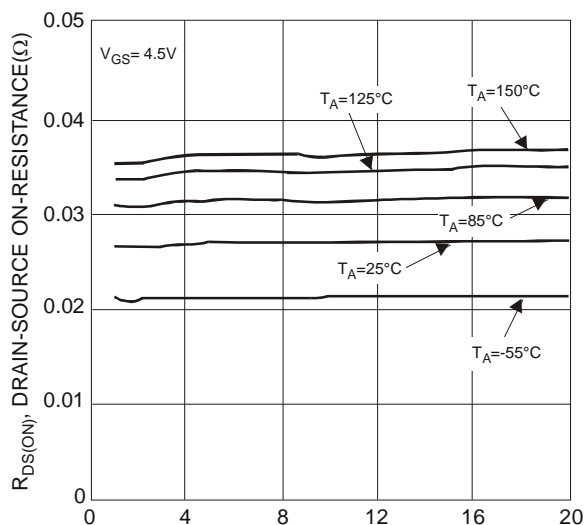


Fig. 4 Typical On-Resistance vs. Drain Current and Temperature

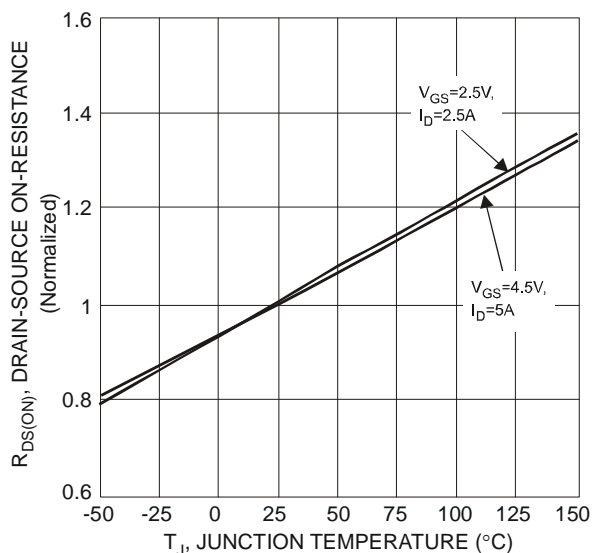


Fig. 5 On-Resistance Variation with Temperature

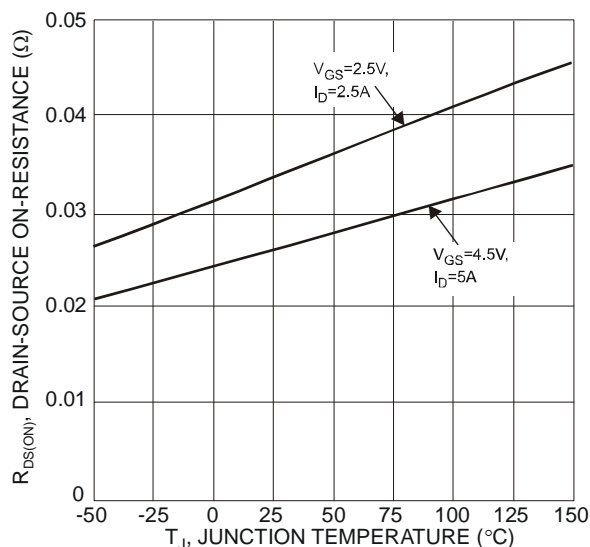


Fig. 6 On-Resistance Variation with Temperature

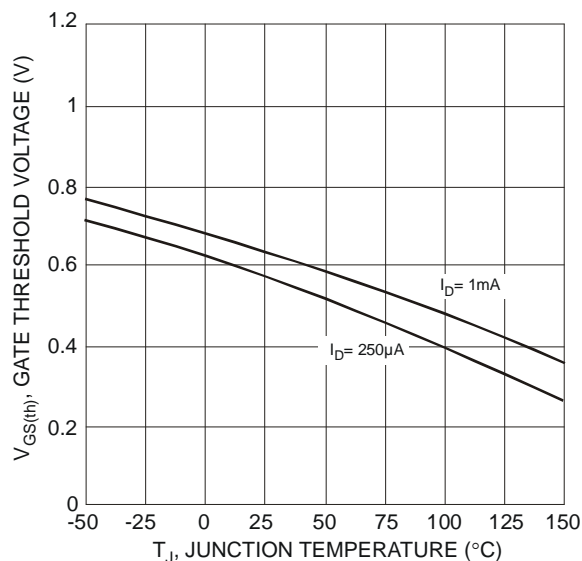


Fig. 7 Gate Threshold Variation vs. Ambient Temperature

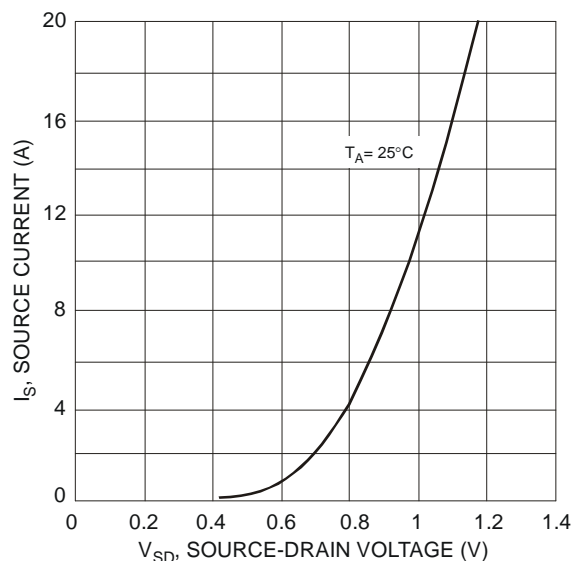


Fig. 8 Diode Forward Voltage vs. Current

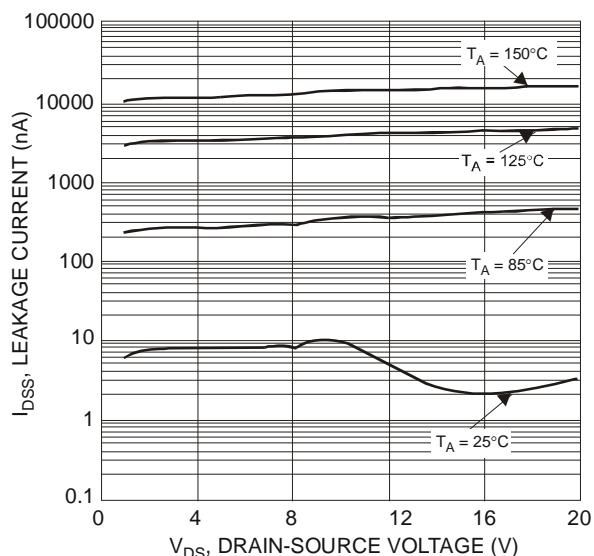


Fig. 9 Typical Drain-Source Leakage Current vs. Voltage

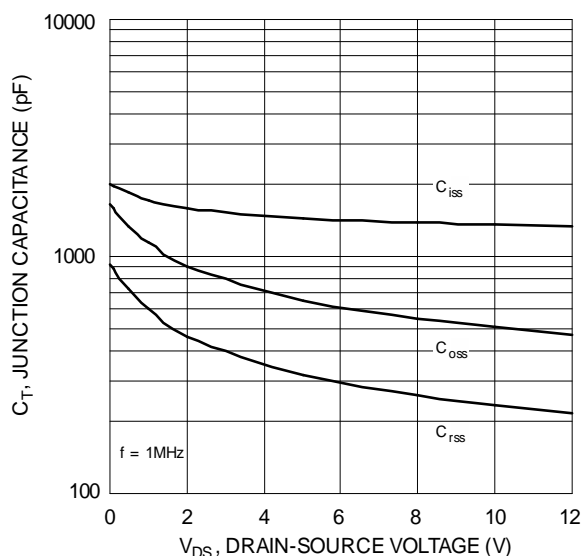


Fig. 10 Typical Junction Capacitance

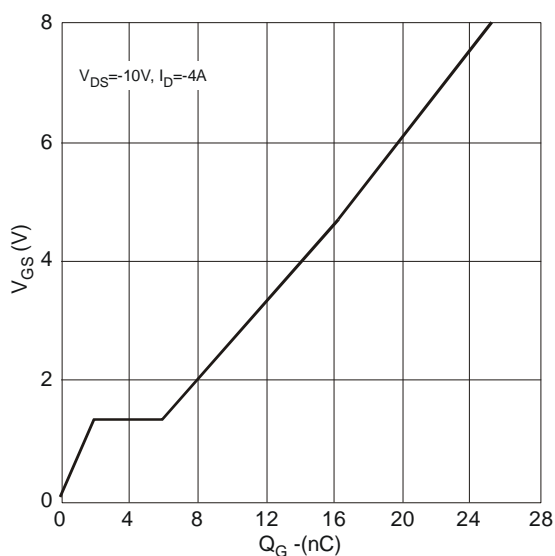


Fig. 11 Gate Charge Characteristics

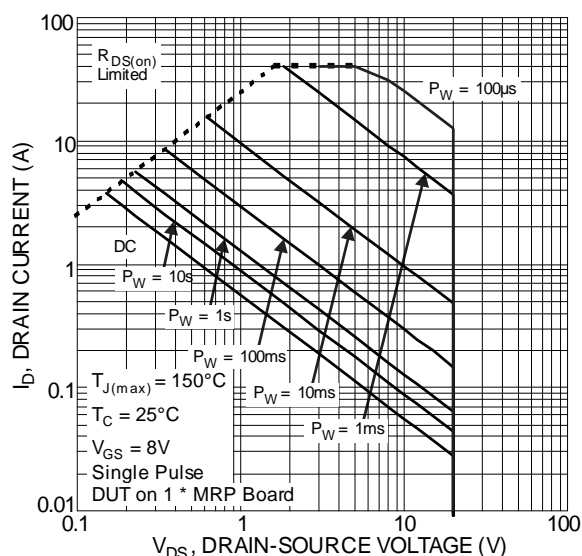


Figure 12 SOA, Safe Operation Area

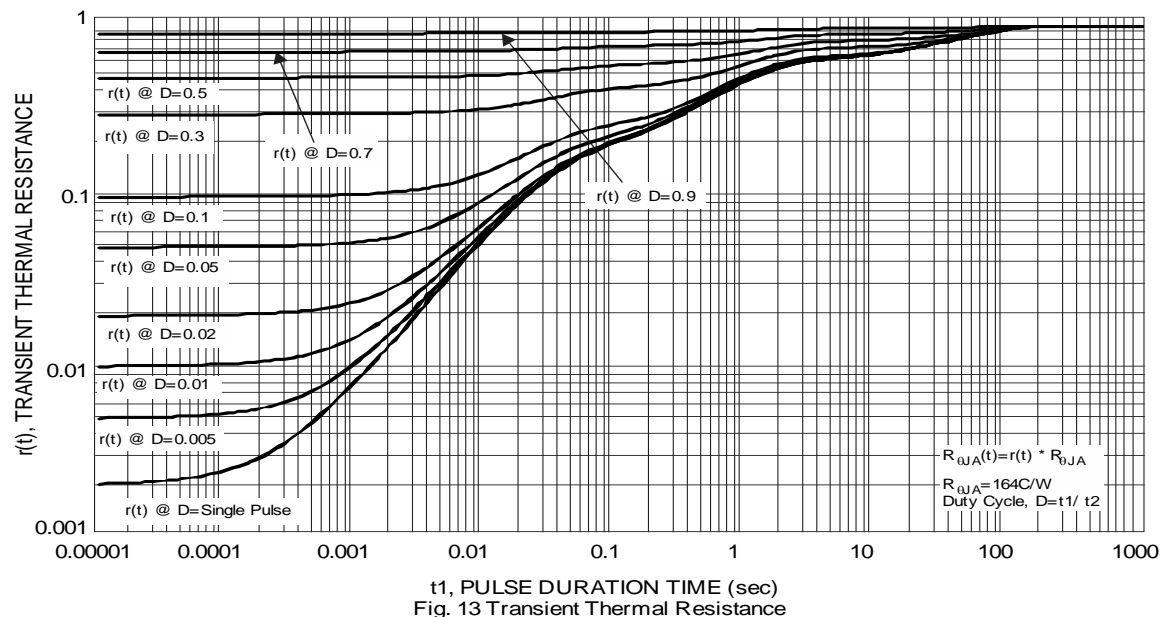
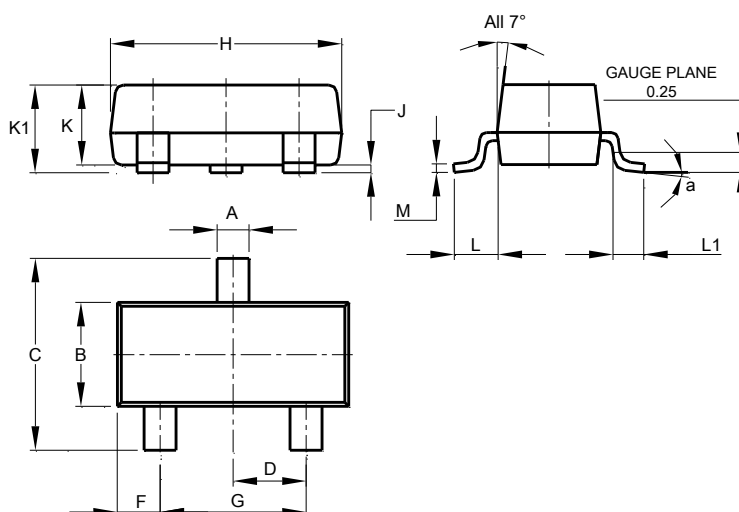


Fig. 13 Transient Thermal Resistance

Package Outline Dimensions

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

SOT23

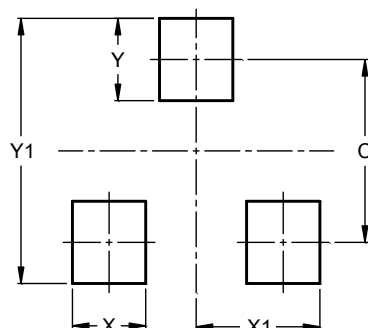


| SOT23 | | | |
|----------------------|-------|-------|-------|
| Dim | Min | Max | Typ |
| A | 0.37 | 0.51 | 0.40 |
| B | 1.20 | 1.40 | 1.30 |
| C | 2.30 | 2.50 | 2.40 |
| D | 0.89 | 1.03 | 0.915 |
| F | 0.45 | 0.60 | 0.535 |
| G | 1.78 | 2.05 | 1.83 |
| H | 2.80 | 3.00 | 2.90 |
| J | 0.013 | 0.10 | 0.05 |
| K | 0.890 | 1.00 | 0.975 |
| K1 | 0.903 | 1.10 | 1.025 |
| L | 0.45 | 0.61 | 0.55 |
| L1 | 0.25 | 0.55 | 0.40 |
| M | 0.085 | 0.150 | 0.110 |
| a | 0° | 8° | -- |
| All Dimensions in mm | | | |

Suggested Pad Layout

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

SOT23



| Dimensions | Value (in mm) |
|------------|---------------|
| C | 2.0 |
| X | 0.8 |
| X1 | 1.35 |
| Y | 0.9 |
| Y1 | 2.9 |

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